PRODUCT SPECIFICATION

HIGH SPEED MODULAR JACK CAT 5E RIGHT ANGLE SHIELDED

1.0 SCOPE

This specification covers the Molex Cat 5e shielded product line which comprises a shielded plug (male) and a jack (female) I/O type connector.

This system contains external shield to provide enhanced ESD protection. Where applicable, tests are in accordance with, or in excess of IEC 60603-7-3.

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER(S)

85543 - **** Series high speed modular jack right angle true SMT shielded, 85505 - **** Series high speed modular jack right angle through hole shielded.

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See the appropriate sales drawings for information on dimensions, materials, plating and markings.

Contact Finish: Gold

post plate 0.00127mm-0.00152mm gold in contact area.

0.00190mm min pure tin in tail area, both over 0.00127mm min nickel overall.

or,

Palladium Nickel With Gold Flash:

post plate 0.00005mm min gold flash over 0.00060mm min palladium nickel in contact area, 0.00190mm min pure tin in tail area, both over 0.00127mm min nickel overall.

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

See the appropriate Sales Drawings and the other sections of this specification for the necessary referenced documents and specifications.

IEC-60603-7-3 TIA-1096-A

4.0 RATINGS

4.1 VOLTAGE

125 Volts DC

4.2 CURRENT

1.5 Amps

4.3 TEMPERATURE

DEVICIONAL ECD/ECN INFORMATIONAL TITLE.

Operating: $-\frac{40}{0}$ °C to $+\frac{85}{0}$ °C Non-operating: $-\frac{40}{0}$ °C to $+\frac{85}{0}$ °C

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PRODUCT SPECIFICATION

5.0 TEST SCHEDULES

For a complete test sequence, a minimum of 63 specimens are needed.

This equals 6 groups of 10,

- 1 group of 2. The group of 2 is for transmission testing, group EP, and
- 1 group of 1. The 1 connector shall be used for test group GP "Shield Performance".

All connectors in each group shall undergo the following tests as described in the sequence given, required alteration of the sequence of tests or adding of new tests to verify additional connector characteristics.

All the test group specimens shall be subjected to the preliminary group P tests in the following sequence.

Test group P

DEVICION. FOR/ECN INFORMATION. TITLE.

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
P1	GENERAL EXAMINATION	Visual examination	There shall be no defects that would impair normal
	PER IEC 60512-1-1, Test 1a		operation
	CONTACT RESISTANCE	Shield contact	Contact
P 2	IEC 60512-2-1, Test 2a	between the fixed and free connector.	resistance 20 mΩ maximum
	CONTACT RESISTANCE		_
P 3	IEC 60512-2-1, Test 2a	Input to output resistance of shield	100 mΩ maximum
P 4	INSULATION RESISTANCE	Test voltage 100 Vd.c. Method A	500 MΩ Minimum
	IEC 60512-3-1, Test 3a, Method a.	mated connectors	
	VOLTAGE PROOF	Contact/contact Method A Mated connector	1000 V d.c. or a.c. peak
P 5	IEC 60512-4-1, Test 4a, Method a.	All signal contacts to shield: Method A Mated connector	1500 V d.c or a.c. peak

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PRODUCT SPECIFICATION

Test group AP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 1	INSERTION AND WITHDRAWAL FORCES PER IEC 60512-13-2, Test 13b	Connector locking device depressed.	Insertion force 30 N max, Withdrawal force 30 N max.
AP 2		N/A	
AP 3	RAPID CHANGE OF TEMPERATURE PER IEC 60068-2-14	-40°C to 70°C Mated connectors 25 cycles I = 30 min recovery time 2 h	
AP 4	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100V ±15 V d.c. method a mated connectors	PER P4
AP 5	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P2	20 mΩ maximum change from initial
AP 6	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
AP 7	VISUAL EXAMINATION	PER P1	PER P1
AP 8	CYCLIC DAMP HEAT PER IEC 60068-2-38	21 cycles low temperature 25°C high temperature 65°C cold subcycle –10°C humidity 93 % Half of the samples in mated state Half of the samples in unmated state	
AP 9	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	Input to output resistance 100 mΩ max.

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PRODUCT SPECIFICATION

Test group AP(continued).

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AP 10	INSERTION AND WITHDRAWAL FORCES	PER AP1	PER AP1
	PER IEC 60512-13-2, Test 13b		
AP 11		N/A	
AP 12	VISUAL EXAMINATION	PER P1	PER P1
AP 13	SOLDERABILITY	Solder Bath 260+0/-5°C Immersion Time 2,0 +/- 0.5s	The Dipped surface shall be covered with a smooth and bright solder coating. Some imperfections are acceptable but NOT concentrated in the same area.
AP 14	RESISTANCE TO SOLDERING HEAT	For recommended Reflow Profile (See Section 6.0)	Appearance: No Damage.
AP 15	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5

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PRODUCT SPECIFICATION

Test group BP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
BP 1		N/A	
BP 2	MECHANICAL OPERATIONS PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 1s (when mated and when unmated) Locking device inoperative.	
BP 3	FLOWING MIXED GAS CORROSION PER IEC 60512-11-7, Test 11g	Method 1, 4 days Half of the samples in mated state Half of the samples in unmated state	
BP 4	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	100 mΩ maximum.
BP 5	MECHANICAL OPERATIONS PER IEC 60512-9-1, Test 9a	Mate connectors 1,250 cycles, at a maximum rate of 10mm/s maximum. Rest 5s (when unmated) locking device inoperative.	
BP 6	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	100 mΩ maximum.
BP 7	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 v ±15 v d.c. Method A mated connectors	PER P4
BP 8	VOLTAGE PROOF IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
BP 9	VISUAL EXAMINATION	PER P1	PER P1

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PRODUCT SPECIFICATION

Test group CP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
CP 1	VIBRATION	f = 10 Hz to 500 Hz, Amplitude: 0.35 mm Accel 50m/s² 10 sweeps / axis measurement points per section 7.0	Discontinuities 10µs maximum.
	PER IEC 60512-6-4, Test 6d (See Section 7.0)	(For arrangement,See IEC 60603-7, 7.3)	
CP 2	CONTACT RESISTANCE No disturbance of the free connector to fixed connector electrical connections, between vibration test and contact resistance measurement IEC 60512-2-1, Test 2a	PER P3	100 mΩ maximum.
CP 3	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	PER P4	PER P4
CP 4	VISUAL EXAMINATION	PER P1	PER P1

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Test group DP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
DP 1	ELECTRICAL LOAD AND TEMPERATURE	500 h 70° C Recovery period 2 h	1.6A Shield contacts 5 connectors, no current 5
	PER IEC 60512-9-2, Test 9b		connectors
	INSULATION RESISTANCE		
DP 2	IEC 60512-3-1, Test 3a, Method a.	PER P4	PER P4
	VOLTAGE PROOF		
DP 3	IEC 60512-4-1, Test 4a, Method a.	PER P5	PER P5
DP 4	VISUAL EXAMINATION	PER P1	PER P1
DP 5	CONTACT RESISTANCE IEC 60512-2-1, Test 2a	PER P3	100 mΩ maximum.
DP 6	MECHANICAL GAUGING PER IEC 60603-7-3, Annex L	Both, free and fixed Connector	Passing go / no go test
DP 7	GAUGING CONTINUITY PER IEC 60603-7-3, Annex A	All signal contacts and screen/specimens	10 μs maximum

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PRODUCT SPECIFICATION

Test group EP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
EP 1	INSERTION LOSS IEC 60512-27-1,Test a	All pairs, one direction.	≤0,04x √f dB from 1 MHz to 100MHz
EP 2	NEXT IEC 60512-27-3, Test c	All pairs, both directions, (pair to pair)	All Pairs: ≥ 83 – 20log(f) dB from 1 MHz to 100 MHz
EP 3	RETURN LOSS IEC 60512-27-2, Test b	All pairs, both directions	All Pairs: ≥ 60 – 20log(f) dB from 1 MHz to 100 MHz
EP 4	FEXT IEC 60512-27-4, Test d	All pairs, both directions, (pair to pair)	All Pairs: ≥ 75, 1 – 20log(f) dB from 1 MHz to 100 MHz
EP 5	TRANSVERSE CONVERSION LOSS IEC 60512-27-6, Test f		All Pairs: ≥ 68 – 20log(f) dB from 1 MHz to 100 MHz
EP 6	TRANSVERSE CONVERSION TRANSFER LOSS IEC 60512-27-7, Test g		All Pairs: ≥ 68 – 20log(f) dB from 1 MHz to 100 MHz
EP 7	INPUT TO OUTPUT RESISTANCE PER IEC 60512-2-1, Test 2a	Mate Connectors	Mated Connectors Cable termination to Cable Termination All types: 200 mΩ maximum.
EP 8	RESISTANCE UNBALANCE IEC 60512-2-1,Test 2a PER IEC 60603-7-3	Millivolt level method	Unbalance resistance = 50 mΩ maximum.

Test group FP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
FP 1	SURGE TEST PER IEC 60512, Test no. ITU_T K.20	Mated connectors, Table 2a /2b, Basic test level Tests 2.1.1a, 2.1.1b, 2.1.3, 2.2.1a and 2.3.1A	Test 2.1 & 2.2: Acceptance criteria A per ITU-T K.44, clause 9, Test 2.3: Acceptance criteria B PER ITU-T K.44, CLAUSE 9,
FP 2	INSULATION RESISTANCE IEC 60512-3-1, Test 3a, Method a.	Test voltage 100 v ±15 v d.c. method a mated connectors	PER P4
FP 3	VISUAL EXAMINATION	PER P1	PER P1

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Test Group GP

TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
GP1	HIGH TEMPERATURE (DRY HEAT) PER IEC 60068-2-2, Test 9b	500 h 70° C Recovery period 2 h	
GP2	CYCLIC DAMP HEAT PER IEC 60068-2-38	21 cycles low temperature 25°C high temperature 65°C cold subcycle –10°C humidity 93 % Half of the samples in mated state Half of the samples in unmated state	
GP4	TRANSFER IMPEDANCE PER IEC 60512-26-100, test 26e	Mate connectors. Measure at frequency from 1 MHz to 80 MHz	All Types: For for $1 \le f \le 10$: $0.1*f^0.301 \Omega$ for $10 \le f \le 80$: $0.02*f \Omega$ where f is the frequency in MHz.
GP5	COUPLING ATTENUATION PER IEC 62153-4-12		[≥ 45 dB from 30MHz to 100MHz ≥ 85 dB from 100 to 1,000 MHz

Test group AZ

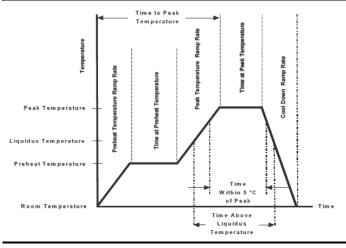
TEST PHASE	TITLE	SEVERITY	REQUIREMENTS
AZ1	HIGH TEMPERATURE (DRY HEAT) PER IEC 60068-2-2, Test 9b	Mate connectors; expose to: 96 hours at 85 ± 2°C	Use Molex plug 500602-0819
AZ 2	CONTACT RESISTANCE	PER P3	20 mΩ maximum change from initial for signal contacts.
722	IEC 60512-2-1, Test 2a		Input to output resistance 100 mΩ max for screen.

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6.0 SOLDERING CONDITIONS. RECOMMENDED

REFLOW SOLDERING SIMULATION P	EAK PROFILE REFLOW AT 260 °C
DESCRIPTION	REQUIREMENT
Solder Type	None
Solder Flux Type	None
Paste Flux Type	None
Average Ramp Rate	3 °C/second maximum
Preheat Temperature	150 °C minimum; 200 °C maximum
Preheat Time	60 to 180 seconds
Ramp to Peak	3 °C/second maximum
Time over Liquidus (217 °C)	60 to 150 seconds
Peak Temperature	260 °C +0/-5 °C
Time within 5 °C of peak	20 to 40 seconds
Ramp - Cool Down	6 °C/second maximum
Time 25 °C to Peak	8 minutes maximum

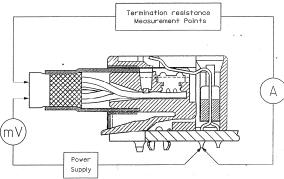


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7.0 GAUGES AND FIXTURE

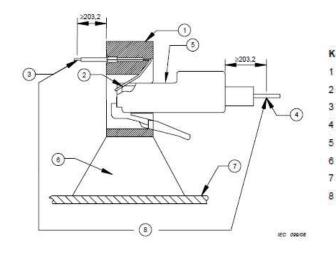
CONTACT RESISTANCE



System resistance equals millivolt drop (mV) divided by test current (A) (Conductor resistance will be deducted from measurement).

VIBRATION

Arrangement for vibration test (test phase CP1)



Fixed connector vibration feature.

Contact point.

Point A; secure to the non-vibrating member.

Point C: secure to the non-vibrating member.

Free connector.

Fixed connector rigidly fixed to the mounting plate.

Mounting plate.

Contact resistance measurement point.

Arrangement for vibration test FROM IEC-60603-7

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CREATED / REVISED BY:
D.Byrnes

TITLE:

CHECKED BY: **A.Higgins**

APPROVED BY: StGriffin

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Parts shall be packaged to protect against damage during handling, transit and storage.

9.0 QUALITY ASSURANCE PROVISIONS

The applicable Molex inspection plan specifies the sampling acceptable quality level to be used. Dimensioned and functional requirements shall be in accordance with applicable product drawings and this specification.

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